**Product** 

ET Thermistor

Part No.

503ET-1S87L-40203

Spec. No.

: S04-0203

Application

: Thermometer

ACCEPTED BY CUSTOMER
Signature

CHECKED BY	SUBMITTED BY



SPECIFICATIONS	User Part No.;	Approved	Checked	Drawn
Application; Thermometer	Part No. ; 503ET-1S87L-40203	H Ishida	m.miyake	X. Egawa

1. Scope

This specification defines rating, dimensions, electric properties, mechanical properties and climatic properties for the following part.

2. Part No.

503ET-1S87L-40203

3. Rating and Characteristic

3.1 Rated zero-power resistance

R25

49.460 kohm ~ 50.542 kohm

3.2 Tolerance on rated zero-power resistance

R25

+/- 0.09 % / group

Group	Resistance(kohm) Min. / Center / Max	Group	Resistance(kohm) Min. / Center / Max
С	49.460 / 49.505 / 49.549		50.000 / 50.045 / 50.090
D	49.550 / 49.595 / 49.639	J	50.091 / 50.136 / 50.180
E	49.640 / 49.685 / 49.729	K	50.181 / 50.226 / 50.270
F	49.730 / 49.775 / 49.819	L	50.271 / 50.316 / 50.360
G	49.820 / 49.865 / 49.909	М	50.361 / 50.406 / 50.451
Н	49.910 / 49.955 / 49.999	N	50.452 / 50.497 / 50.542

Remark : the resistance values may vary slightly as the testing temperature is ± 0.03°C in accuracy.

3.3 Rated B-value

B<sub>25/85</sub> 4 055 K

(The B-value is calculated from R25 and R85)

3.4 Tolerance on rated B-value

B25/85 +/- 1 %

3.5 Thermal time constant

Approx. 3.2 s

(in still air)

3.6 Dissipation factor

Approx. 0.7 mW/deg. C (in still air)

3.7 Rated maximum power dissipation

Approx. 3.5 mW

(in still air)

(Including self-heat of approx. 5 deg. C)

4. Category temperature range

-40 deg. C ~ 100 deg. C

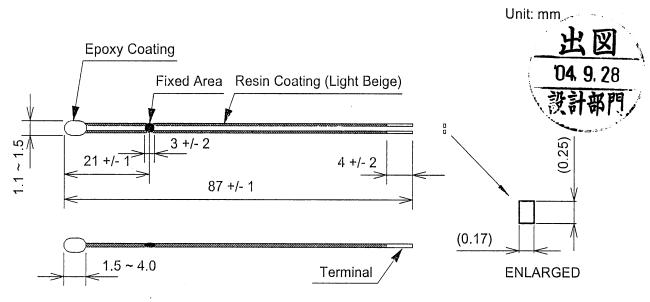
5. Storage temperature range

-10 deg. C ~ 40 deg. C

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### 6. Dimensions



### 7. Properties

7.1 Electric properties

ltem	Test Conditions	Criteria
	Measured at DC 100 V between part of the epoxy coating and terminals.	Over 100 M ohm.

7.2 Mechanical properties

Item	Test Conditions	Criteria
7.2.1	After 1N loading weight was applied to the wire	Variation of R25 and
Tensile of terminations	terminations for 10 s +/- 1 s.	B25/85 after test shall be
	∬ 0.5 N	within +/- 1 % of those of
	<u>→</u> 1 N	the initial values.
	rubber	No visible damage.
7.2.2	After three times natural fall to a maple board	Variation of R25 and
Free fall	from 1 m high.	B25/85 after test shall be
		within +/- 1 % of those of
		the initial values.
		No visible damage.
7.2.3	Terminals of the test samples shall be one time	Soldered area, more than
Solderability	immersed into solder bath at 245 deg. C +/- 5	90 %.
	deg. C for $2 s \sim 3 s$ .	
	Solder: Sn-3.0Ag-0.5Cu	
	flux : rosin 25 %, ethyl alcohol 75 %	

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7.2.4	Terminals of the test samples shall be one time	
Resistance to	immersed into solder bath at 260 deg. C +/- 5	B25/85 after test shall be
soldering heat	deg. C for 10 s +/- 1 s.	within +/- 1 % of those of
		the initial values.
		No visible damage.

7.3. Climatic properties

7.3. Climatic properti		
ltem	Test Conditions	Criteria
7.3.1	At -40 deg. C +/- 3 deg. C for 1 000 h and then	Variation of R25 and
Cold	stored at room temperature and humidity for 1 h.	B25/85 after test shall be within +/- 1 % of those of the initial values.
7.3.2	At 100 deg. C +/- 3 deg. C for 1 000 h and then	Variation of R25 and
Dry heat	stored at room temperature and humidity for 1 h.	B25/85 after test shall be within +/- 1 % of those of the initial values.
7.3.3	100 times in the following order and conditions	Variation of R25 and
Change of temperature	and then stored at room temperature and	B25/85 after test shall be
	humidity for 1 h	within +/- 1 % of those of
	"Room temperature (Initial value)." " -20 deg. C +/- 3 deg. C for 5 min".	the initial values.
	"Room temperature for 3 min".	-4
	" 100 deg. C +/- 3 deg. C for 5 min".	04.
	"Room temperature for 3 min".	沙計
7.3.4	At 40 deg. C +/- 3 deg. C, 90 %RH ~ 95 %RH	Variation of R25 and
Damp heat	for 1 000 h and then stored at room	B <sub>25/85</sub> after test shall be
	temperature and humidity for 1 h.	within +/- 1 % of those of
		the initial values.
7.3.5	At 40 deg. C +/- 3 deg. C, 90 %RH ~ 95 %RH	Variation of R25 and
Damp heat	with the DC 0.1 mA load for 1 000 h and then	B25/85 after test shall be
(Under loading)	stored at room temperature and humidity for 1 h.	within +/- 1 % of those of the initial values.

### Note

### 8. Quantity balance

A Quantity balance of the tolerance group per shipment shall not be specified in purchase order. Quantity of each group may depend on production result.

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<sup>&</sup>quot;Room temperature" is defined as the temperature between 15 deg.C to 35 deg.C.

<sup>&</sup>quot;Room humidity" is defined as the humidity between 25 %RH to 75 %RH.

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### Revision records

Revision No.	Date	Revised by	Revision item	Former specification	New specification	
A					出	区
В					704.5	3.2
С						
D						
E						
F				·		
G						
Н						
I						
J						